

Search Notes

Application/Control No.

09/771,210

Examiner

Huy Q. Phan

Applicant(s)/Patent under
Reexamination

ACHOUR, BAAZIZ

Art Unit

2617

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|----------|----------|
| 455 | 453 | 06/21/06 | HQ |
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| 370 | 320 | | |
| | 331 | 06/21/06 | HQ |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| EAST SEARCH (see attached) | 06/21/06 | HQ |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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